

**Search Notes**

Application/Control No.

10/811,065

Examiner

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Applicant(s)/Patent under  
Reexamination

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Art Unit

1762

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
427	160,180	10/30/2006	AB
427	205,419.2	10/30/2006	AB
106	287.19	10/30/2006	AB
106/400,401,712		10/30/2006	ab

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
previous search updated	10/30/2006	ab